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Bib Data Sheet

CONFIRMATION NO. 8283

SERIAL NUMBE 10/749,031	•		CLASS 324		GROUP ART UNIT 2829		ATTORNEY DOCKET NO. 1880-031569		
APPLICANTS .									
William H. Howland JR., Wexford, PA;									
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"* CONTINUING DATA "****************** *** FOREIGN APPLICATIONS ********* *** FOREIGN APPLICATIONS ******** *** FOREIGN APPLICATIONS ********** *** SMALL ENTITY *** *** 04/28/2004									
Foreign Priority claimed yes no 35 USC 119 (a-d) conditions yes no Met after met				STATE OR COUNTRY PA		AWING CLA		TAL AIMS	INDEPENDENT CLAIMS 3
Acknowledged Examiner's Signature Initials PA 4 18 3 ADDRESS 28289 WEBB ZIESENHEIM LOGSDON ORKIN & HANSON, P.C. 700 KOPPERS BUILDING 436 SEVENTH AVENUE PITTSBURGH , PA 15219									
TITLE Method and apparatus for determining the dielectric constant of a low permittivity dielectric on a semiconductor wafer									
FILING FEE	FEES: Authority has been given in Paper					☐ All Fees ☐ 1.16 Fees (Filing) ☐ 1.17 Fees (Processing Ext. of time)			
RECEIVED	Noto charge/credit DEPOSIT ACCOUNT Nofor following:				1.18 Fees (Issue)				
385						Other			